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APPLICATION NO.	FI	LING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
10/731,144	12/10/2003		Sang Wook Ryu	P69368US0	4774
136	7590	10/04/2004		EXAM	INER
JACOBSO1			DANG, TRUNG Q		
400 SEVEN' SUITE 600	IH SIKE	EI N.W.		ART UNIT	PAPER NUMBER
WASHINGT	ON, DC	20004	2823	-	

DATE MAILED: 10/04/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)					
	10/731,144	RYU, SANG WOOK					
Office Action Summary	Examiner	Art Unit					
	Trung Dang	2823					
The MAILING DATE of this communication Period for Reply	n appears on the cover sheet w	ith the correspondence address					
A SHORTENED STATUTORY PERIOD FOR RITHE MAILING DATE OF THIS COMMUNICATION - Extensions of time may be available under the provisions of 37 Clafter SIX (6) MONTHS from the mailing date of this communication - If the period for reply specified above is less than thirty (30) days, If NO period for reply is specified above, the maximum statutory provided in the second specified above is less than thirty (30) days, If NO period for reply is specified above, the maximum statutory provided in the second specified above is less than thirty (30) days, any reply received by the Office later than three months after the earned patent term adjustment. See 37 CFR 1.704(b).	ON. FR 1.136(a). In no event, however, may a in. a reply within the statutory minimum of this eriod will apply and will expire SIX (6) MOI statute, cause the application to become A	reply be timely filed ty (30) days will be considered timely. NTHS from the mailing date of this communication. BANDONED (35 U.S.C. § 133).					
Status							
1) Responsive to communication(s) filed on	•						
	This action is non-final.						
3) Since this application is in condition for all	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
closed in accordance with the practice und	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Disposition of Claims							
4)⊠ Claim(s) 1-11 is/are pending in the applica	• • •						
5) Claim(s) 4-11 is/are allowed.							
6)⊠ Claim(s) <u>1-3</u> is/are rejected.							
7) Claim(s) is/are objected to.		·					
8) Claim(s) are subject to restriction a	nd/or election requirement.						
Application Papers							
9) The specification is objected to by the Exa	miner.						
10) The drawing(s) filed on is/are: a)	The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.						
Applicant may not request that any objection to	the drawing(s) be held in abeya	nce. See 37 CFR 1.85(a).					
Replacement drawing sheet(s) including the co	orrection is required if the drawing	(s) is objected to. See 37 CFR 1.121(d).					
11)☐ The oath or declaration is objected to by th	e Examiner. Note the attache	d Office Action or form PTO-152.					
Priority under 35 U.S.C. § 119							
12)⊠ Acknowledgment is made of a claim for for a)⊠ All b)□ Some * c)□ None of:	reign priority under 35 U.S.C.	§ 119(a)-(d) or (f).					
 Certified copies of the priority docur 	ments have been received.						
Certified copies of the priority docur	ments have been received in A	pplication No					
3. Copies of the certified copies of the	•	received in this National Stage					
application from the International Bu	, , , , , , , , , , , , , , , , , , , ,						
* See the attached detailed Office action for a	a list of the certified copies not	received.					
Attachment(s)							
Notice of References Cited (PTO-892)	4) Interview	Summary (PTO-413)					
2) Notice of Draftsperson's Patent Drawing Review (PTO-946	8) Paper No	s)/Mail Date					
 Information Disclosure Statement(s) (PTO-1449 or PTO/S Paper No(s)/Mail Date 	B/08) 5) Notice of 6) Other:	nformal Patent Application (PTO-152)					

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DETAILED ACTION

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Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claims 1-3 are rejected under 35 U.S.C. 102(b) as being anticipated by Rostoker (US Pat. 5,662,768).

With reference to Figs. 1a to 1f, the reference anticipates the claims in that it discloses a method of forming a trench in a semiconductor device, comprising:

- (a) a step of depositing a first pad film and a second pad film on a semiconductor substrate (col. 5, lines 8-14);
- (b) a step of pattering the first pad film and the second pad film to expose the semiconductor substrate (Fig. 1a);
- (c) a step of implanting Ar ions to the exposed semiconductor substrate to cause lattice defects in an area of the semiconductor substrate into which the ions are implanted through the ion implanting process;
- (d) a step of performing an etching process using a trench etching mask, wherein the area of the semiconductor substrate in which the lattice defects are

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caused in the step of (c) is etched more rapidly than an area in which the lattice defects are not caused, thereby forming the trench (col. 6, lines 1-15; lines 51-63).

Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claim 3 is rejected under 35 U.S.C. 103(a) as being unpatentable over Rostoker as above in view of Yamazaki et al. (US Pat. 5,641,380).

This rejection is made with regard to the inert gases other than Ar as recited in the claim.

Rostoker teaches the method as described above. Rostoker differs from the claim in that while Rostoker implants an inert gas of Ar to cause lattice damage to the implanted semiconductor region, the claim calls for the use of other inert gases such as He, Ne, Kr, or Xe to effectuate the same. Yamazaki in column 2, lines 37-43 teaches implanting inert gas such as Ar, He, Xe, or Kr converts crystalline silicon into amorphous silicon (i.e., crystalline silicon lattice is damaged). The subject matter as a whole would have been obvious to one having ordinary skill in the art at the time the invention was made to implant He, Xe, or Kr in the process of Rostoker

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so as to cause lattice damage to the implanted semiconductor region because the substitution of art recognized equivalents as shown by Yamazaki would have been within the level of one skilled in the art. As for Ne, one of ordinary skill in the art would reasonably expect the same result because Ne is in the same group in the periodic table with the other inert gases.

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- 5. Claims 4-11 are allowed.
- 6. The following is an examiner's statement of reasons for allowance:

Claim 4 and its dependent claims are allowed over prior art of record because the prior art does not teach or suggest the claimed features regarding the steps of performing a first implantation to the substrate exposed between spacers then decreasing the thickness of the spacers thereby increasing the line-width, and then performing a second implantation.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

7. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Trung Dang whose telephone number is 571-272-1857. The examiner can normally be reached on Mon-Friday 9:30am-6:00pm.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Olik Chaudhuri can be reached on 571-272-1855. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Trung Dang Primary Examiner Art Unit 2823

9/30/04